

3.3V PCI Express® 3.0 4 Channel 2x2 Exchange Switch

Features

- 4 Differential Channel 2x2 Exchange Switch
- PCI Express® 3.0 performance, 8.0 Gbps
- Bi-directional operation
- Low Bit-to-Bit Skew: 10ps (between ± signals)
- Low Crosstalk: -29dB @ 2.5GHz (5Gbps)
-20dB @ 4.0GHz (8Gbps)
- Low Insertion Loss: -1.1dB @ 2.5GHz (5Gbps)
-1.45dB @ 4.0GHz (8Gbps)
- V_{DD} Operating Range: 3.3V ±10%
- Industrial Temperature Range: -40°C to 85°C
- ESD Tolerance: 2kV HBM
- Packaging (Pb-free & Green):
 - 30-contact, TQFN (ZL30), 2.5 x 4.5mm.

Description

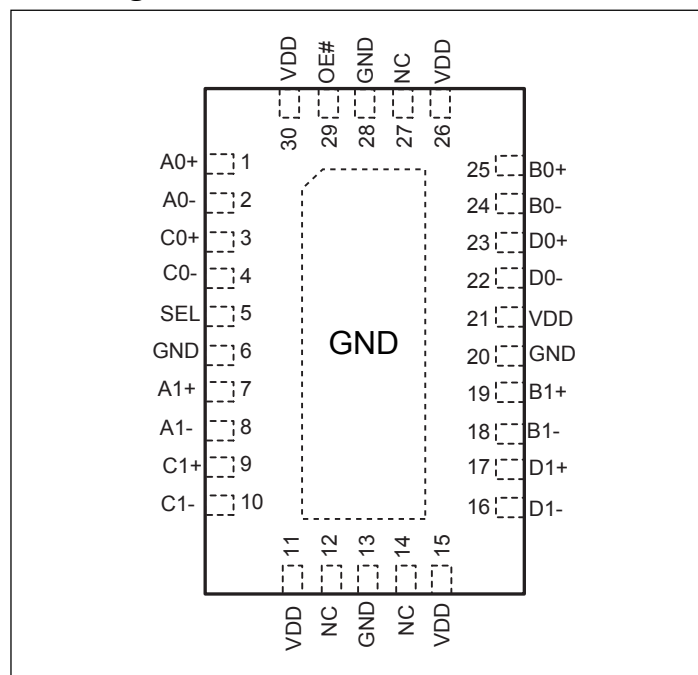
The PI3PCIE3242 is a differential exchange switch featuring pass-through pinout. It supports one full PCI Express® lane 2x2 Exchange Switch operating at 8.0Gbps PCIe® 3.0 performance.

With the select control input low, Port A connects to Port B, and Port C connects to port D for an 8-channel differential pass-through. When the select control input is high Port A connects to Port D, and Port B connects to Port C.

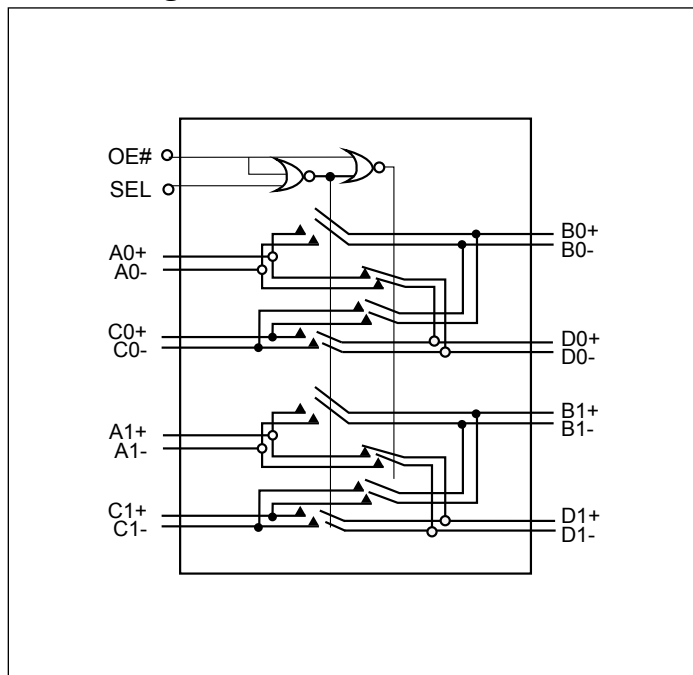
Truth Table

Function	SEL	OE#
Ax = Bx Cx = Dx	0	0
Ax = Dx Cx = Bx	1	0
Ax, Bx, Cx, Dx = Hi-Z (disconnect)	x	1

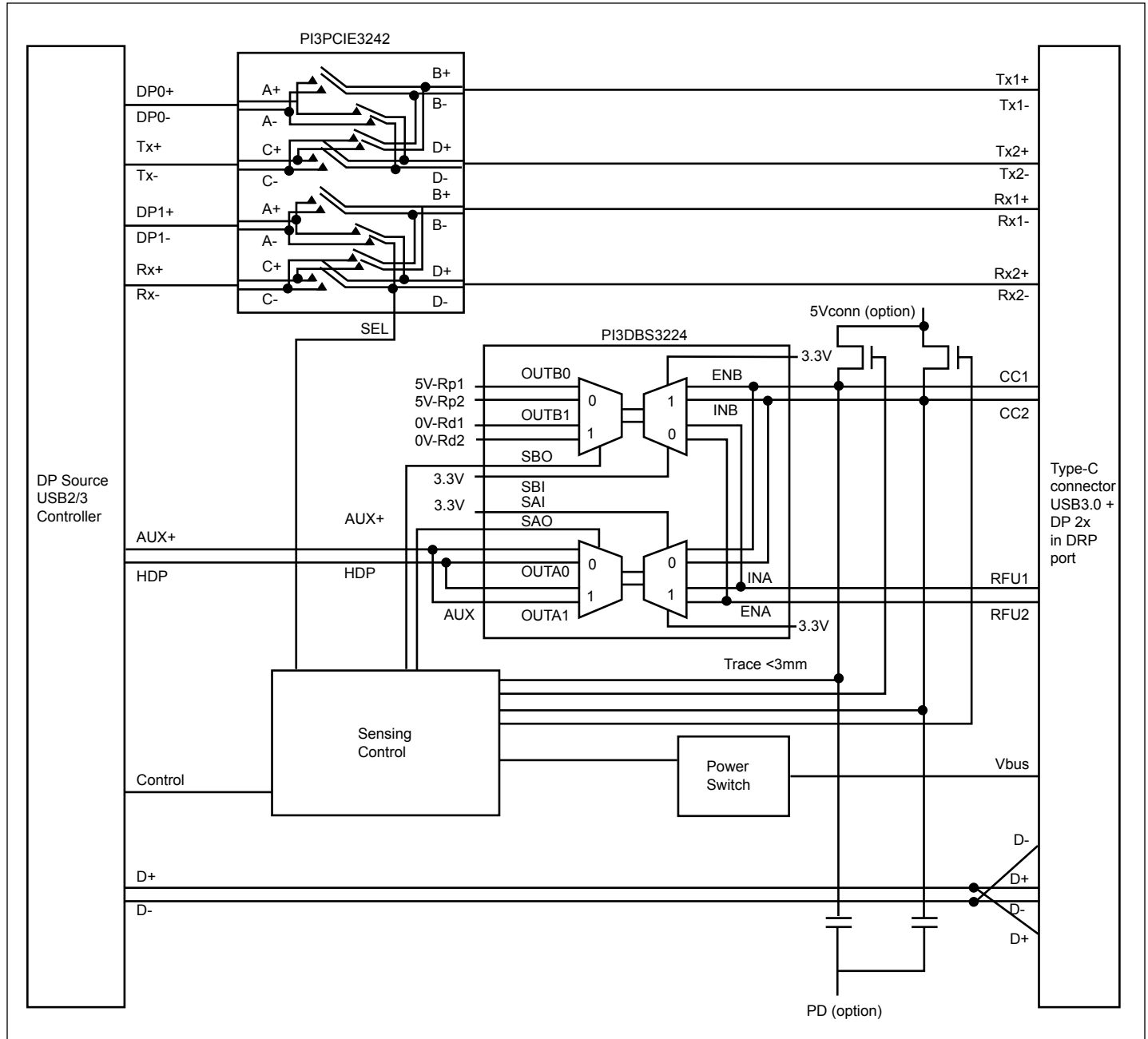
Pin Diagram 30-TQFN



Block Diagram



Application Diagram in Switching 2 Lanes of DP1.2 & USB 3.0 Signals Over Type C Connector Notebook or Tablet



Pin Description (30-TQFN)

Pin #	Pin Name	I/O	Description
1	A0+	I/O	Signal I/O, Channel 0, Port A
2	A0-		
7	A1+	I/O	Signal I/O, Channel 1, Port A
8	A1-		
25	B0+	I/O	Signal I/O, Channel 0, Port B
24	B0-		
19	B1+	I/O	Signal I/O, Channel 1, Port B
18	B1-		
3	C0+	I/O	Signal I/O, Channel 0, Port C
4	C0-		
9	C1+	I/O	Signal I/O, Channel 1, Port C
10	C1-		
23	D0+	I/O	Signal I/O, Channel 0, Port D
22	D0-		
17	D1+	I/O	Signal I/O, Channel 1, Port D
16	D1-		
29	OE#	I	Output Enable, active low. When OE# = 0 the device I/O is enabled. When OE#=1, all I/O are high impedance
5	SEL	I	Operation mode Select (when SEL=0: A→B, C→D, when SEL=1: A→D, C→B)
11, 15, 21, 26, 30	V _{DD}	Pwr	3.3V ±10% Positive Supply Voltage
6, 13, 20, 28, Center Pad	GND	Pwr	Power ground
12, 14, 27	NC		No Connect

Maximum Ratings

(Above which useful life may be impaired. For user guidelines, not tested.)

Storage Temperature	-65°C to +150°C
Supply Voltage to Ground Potential	-0.5V to +4.6V
DC Input Voltage	-0.5V to V_{DD}
DC Output Current	120mA
Power Dissipation	0.5W
Junction Temperature	125°C

Note: Stresses greater than those listed under MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

Electrical Characteristics Recommended Operating Conditions

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Units
V_{DD}	3.3V Power Supply		3.0	3.3	3.6	V
I_{DD}	Total current from V_{DD} 3.3V supply	SEL and OE# at OV or V_{DD}			200	μ A
T_A	Operating temperature range		-40		85	°C

DC Electrical Characteristics for Switching over Operating Range

Parameters	Description	Test Conditions ⁽¹⁾	Min.	Typ. ⁽¹⁾	Max.	Units
V_{IH}	Input HIGH Voltage	Guaranteed HIGH level	$0.65 \times V_{DD}$			V
V_{IL}	Input LOW Voltage	Guaranteed LOW level	-0.5		$0.35 \times V_{DD}$	
V_{IK}	Clamp Diode Voltage	$V_{DD} = \text{Max.}, I_{IN} = -18\text{mA}$		-0.7	-1.2	
I_{IH}	Input HIGH Current, SEL	$V_{DD} = \text{Max.}, V_{IN} = V_{DD}$	-10		+10	μ A
I_{IL}	Input LOW Current, SEL	$V_{DD} = \text{Max.}, V_{IN} = \text{GND}$	-10		+10	
I_{IH}	Input HIGH Current, A_X, B_X, C_X, D_X	$V_{DD} = \text{Max.}, V_{IN} = 1.8\text{V}$	-10		+10	μ A
I_{IL}	Input LOW Current, A_X, B_X, C_X, D_X	$V_{DD} = \text{Max.}, V_{IN} = 0\text{V}$	-10		+10	

Note:

1. Typical values are at $V_{DD} = 3.3\text{V}$, $T_A = 25^\circ\text{C}$ ambient and maximum loading.

Switching Characteristics

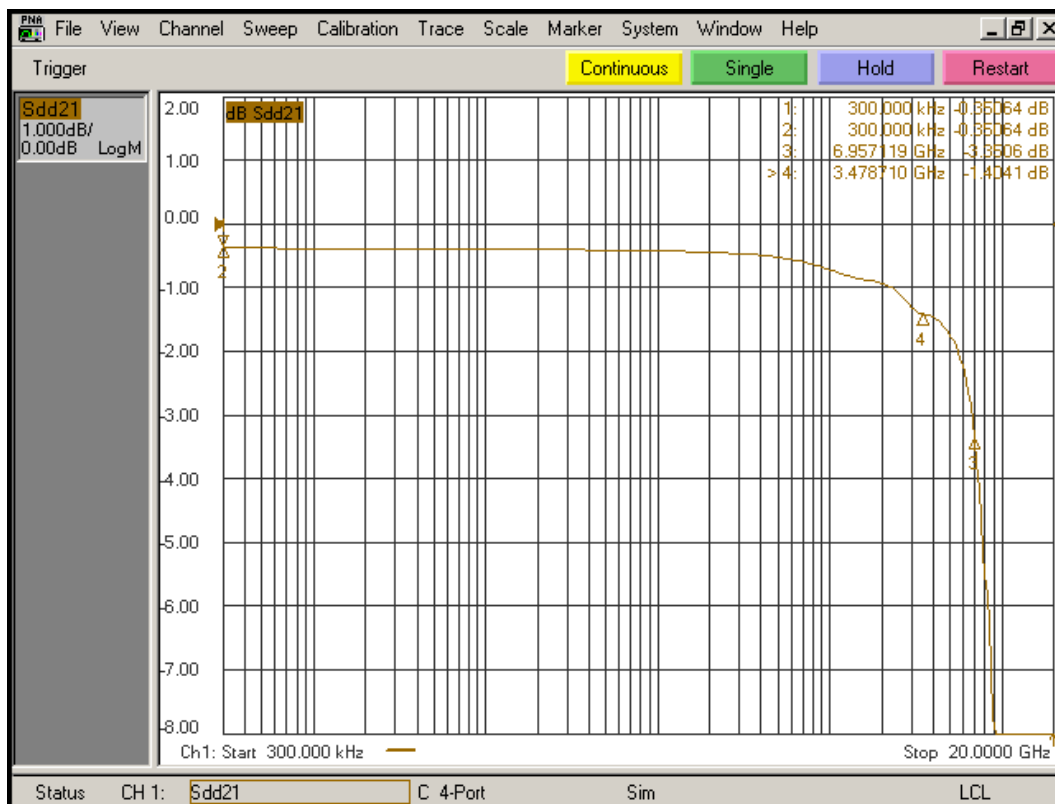
Parameters	Description	Test Conditions	Min.	Typ.	Max.	Units
t_{PZH}, t_{PZL}	Line Enable Time - SEL to A_N, B_N, C_N, D_N		0.5		45	ns
t_{PHZ}, t_{PLZ}	Line Disable Time - SEL to A_N, B_N, C_N, D_N		0.5		25	
t_{b-b}	Bit-to-bit skew within the same differential pair				10	ps
t_{ch-ch}	Channel-to-channel skew				20	

Dynamic Electrical Characteristics

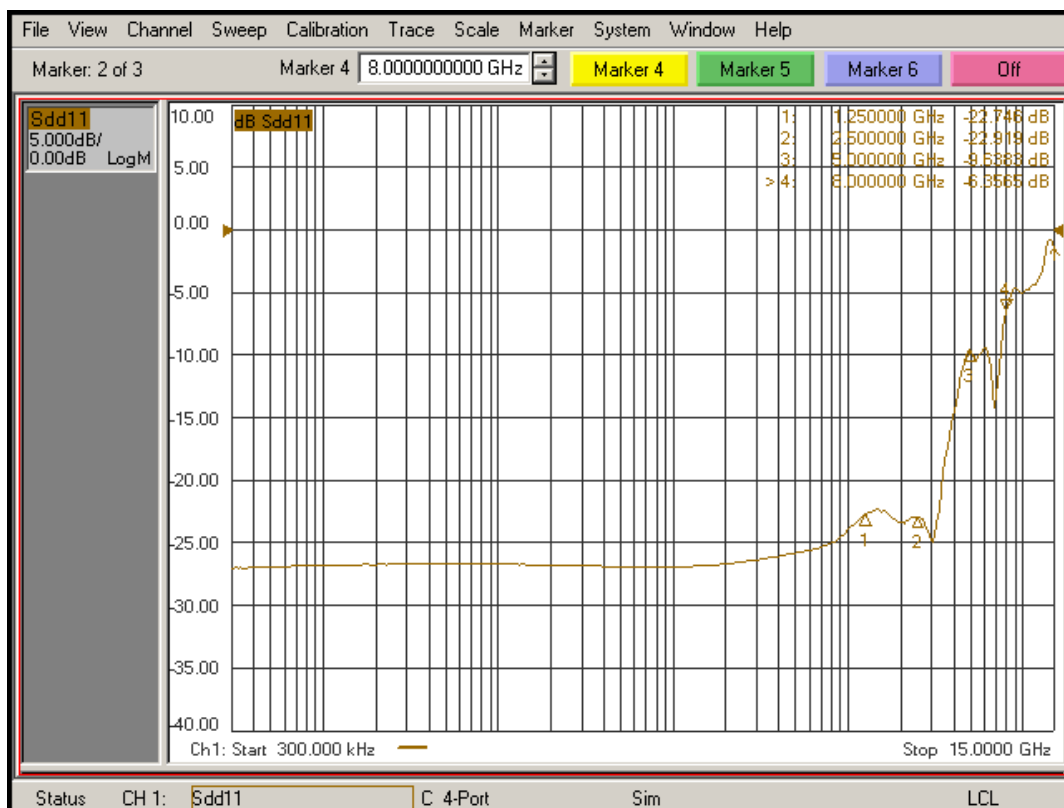
Parameter	Description	Test Conditions	Min.	Typ. ⁽¹⁾	Max.	Units
DDIL	Differential Insertion Loss ($V_{IN} = -10\text{dBm}$, $DC = 0V$)	$f=1.2\text{GHz}$ $f=2.5\text{GHz}$ $f=4.0\text{GHz}$ $f=5.0\text{GHz}$ $f=7.5\text{GHz}$		-0.8 -1.0 -1.3 -1.8 -4.5	-1.0 -1.2 -1.5 -2.0 -5.0	dB
DDIL _{OFF}	Differential Off Isolation	$f= 4.0\text{GHz}$		-19		dB
DDRL	Differential Return Loss	$f= 0$ to 2.8GHz $f= 2.8$ to 5.0GHz $f= 5.0$ to 8.0GHz		-26 -14 -7.5		dB
DDNEXT	Near End Crosstalk	$f= 0$ to 2.8GHz $f= 2.8$ to 5.0GHz $f= 5.0$ to 8.0GHz		-26 -20 -16		dB
V_{IF}	Max Signal Frequency Range	Insertion loss 1.5dB, $V_{IN}=0.623V_{pp}$, $DC=0V$		4.0		GHz
		Insertion loss 1.5dB, $V_{IN}=0.623V_{pp}$, $DC=0.9V$		4.0		
		Insertion loss 3dB, $V_{IN}=0.623V_{pp}$, $DC=0V$		8.0		
		Insertion loss 3dB, $V_{IN}=0.623V_{pp}$, $DC=0.9V$		8.0		
BW	-3dB Bandwidth			6.5		GHz

Notes:

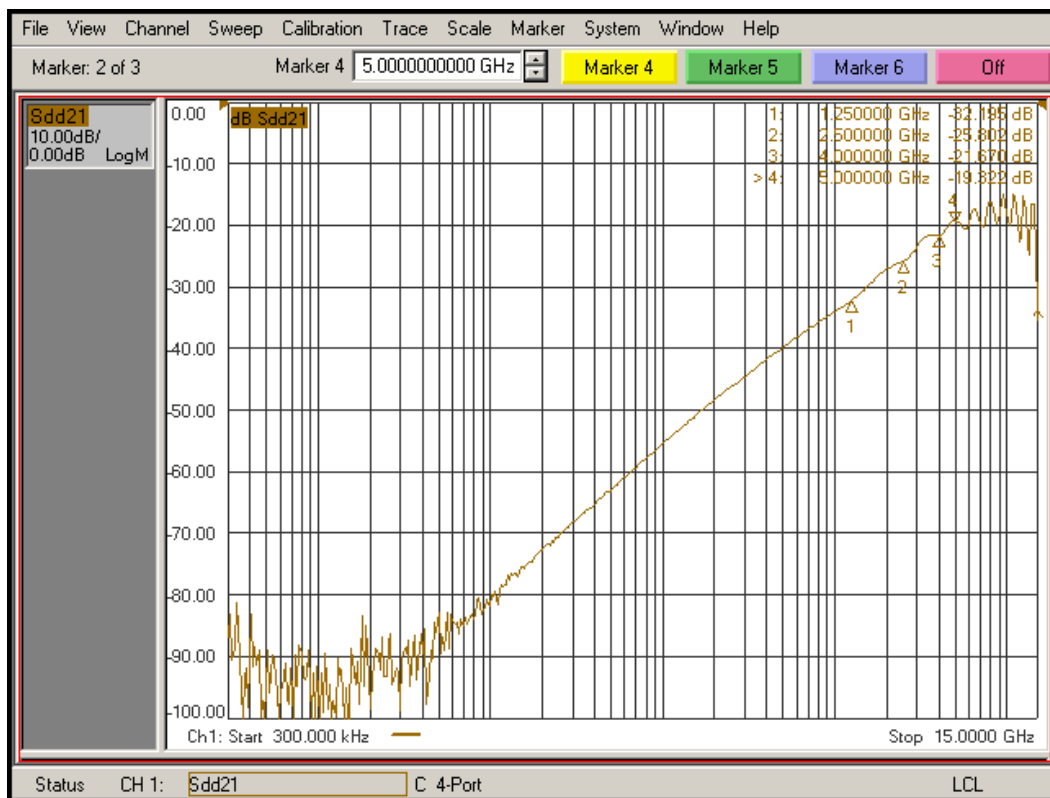
1. Guaranteed by design. Typical values are at $V_{DD} = 3.3V$, $T_A = 25^\circ\text{C}$ ambient and maximum loading.



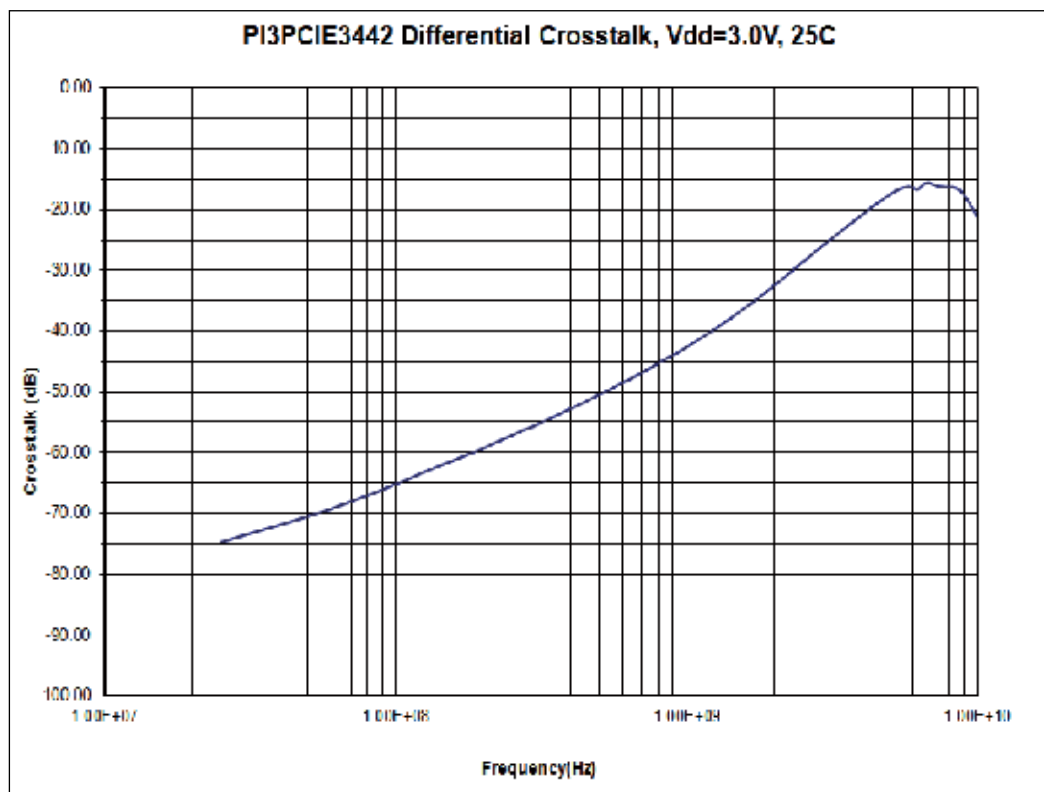
Differential Insertion Loss



Differential Return Loss

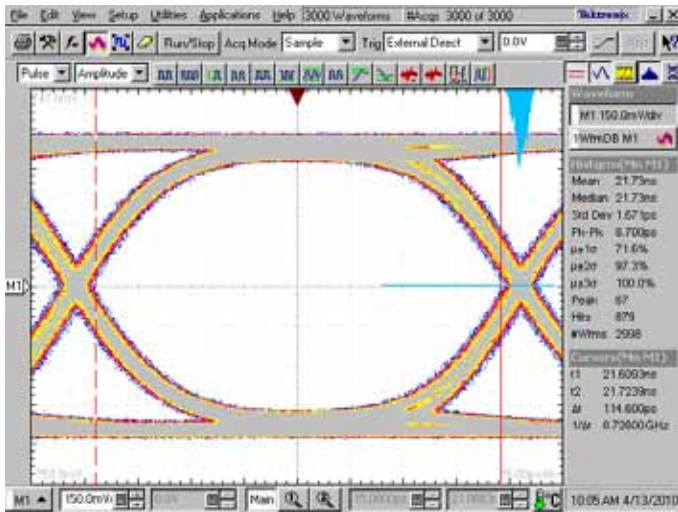


Differential Off Isolation

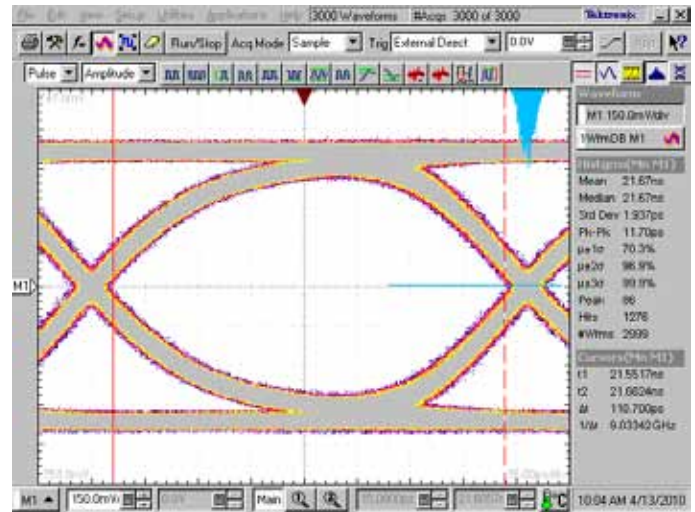


Differential Crosstalk

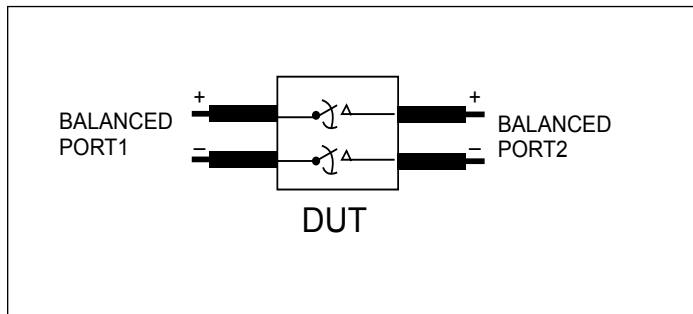
PI3PCIE3242



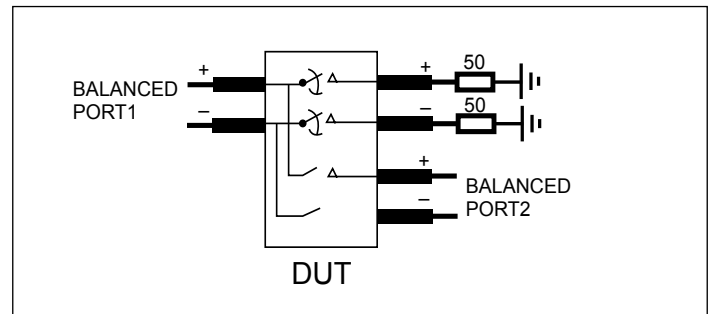
8.0 Gbps RX signal eye without PI3PCIE3242



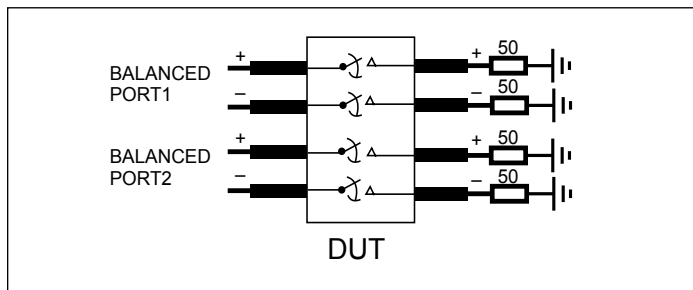
8.0 Gbps RX signal eye with PI3PCIE3242



Differential Insertion Loss and Return Test Circuit

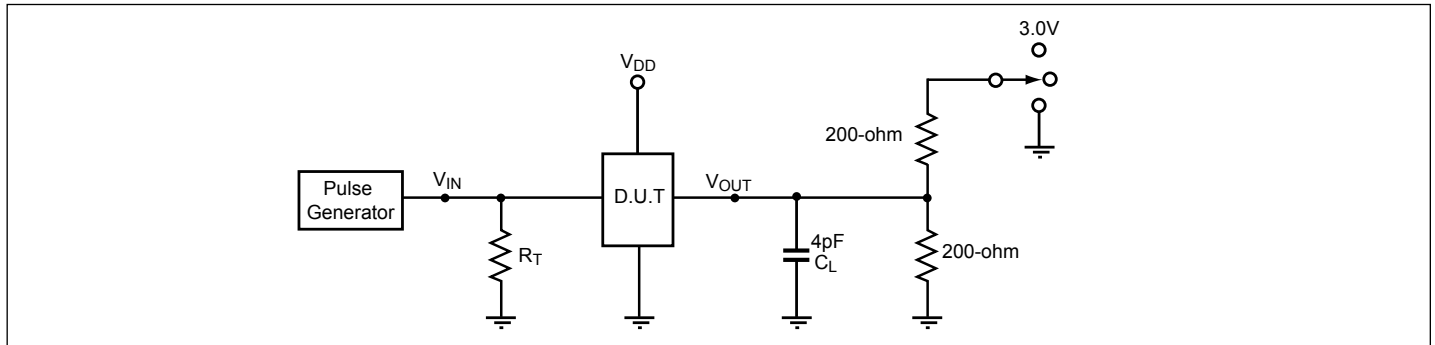


Differential Off Isolation Test Circuit



Differential Near End Xtalk Test Circuit

Test Circuit for Electrical Characteristics⁽¹⁻⁵⁾



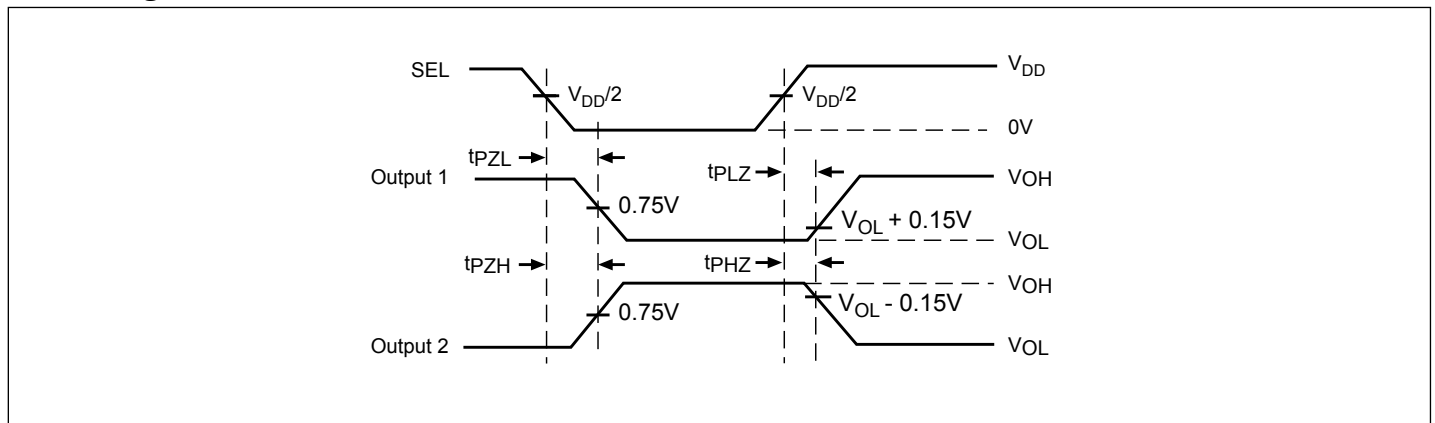
Notes:

1. C_L = Load capacitance: includes jig and probe capacitance.
2. R_T = Termination resistance: should be equal to Z_{OUT} of the Pulse Generator
3. Output 1 is for an output with internal conditions such that the output is low except when disabled by the output control.
output 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
4. All input impulses are supplied by generators having the following characteristics: $PRR \leq \text{MHz}$, $Z_O = 50\Omega$, $t_R \leq 2.5\text{ns}$, $t_F \leq 2.5\text{ns}$.
5. The outputs are measured one at a time with one transition per measurement.

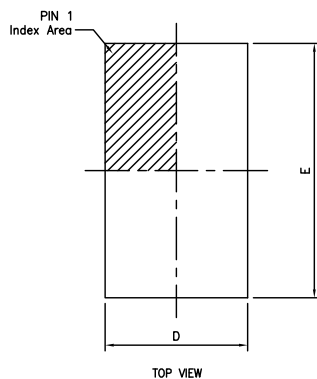
Switch Positions

Test	Switch
t_{PLZ} , t_{PZL}	3.0V
t_{PHZ} , t_{PZH}	GND
Prop Delay	Open

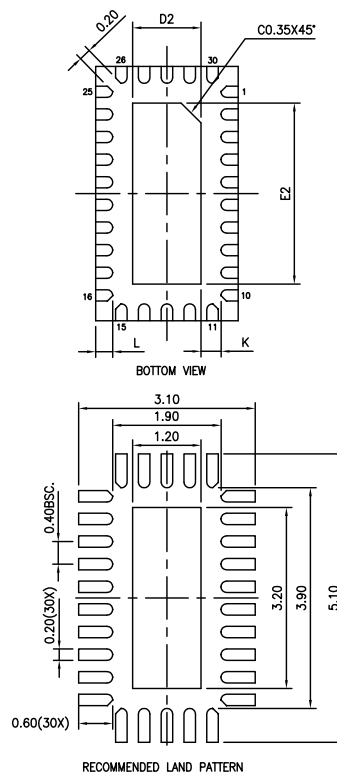
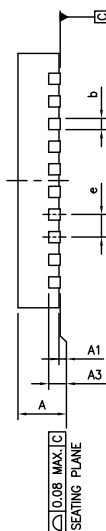
Switching Waveforms



Voltage Waveforms Enable and Disable Times

Packaging Information: 30-Contact TQFN (2.5x4.5mm)


SYMBOLS	MIN.	NOM.	MAX.
A	0.70	0.75	0.80
A1	0.00	0.02	0.05
A3		0.203	REF.
b	0.15	0.20	0.25
D	2.40	2.50	2.60
E	4.40	4.50	4.60
D2	1.15	1.20	1.25
E2	3.15	3.20	3.25
e		0.40	BSC
L	0.25	0.30	0.35
K	0.20	—	—


Notes:

1. All dimensions are in mm. Angles in degrees.
2. Refer JEDEC MO-220.
3. Recommended land pattern is for reference only.



DATE: 10/21/13

DESCRIPTION: 30-contact, Thin Fine Pitch Quad Flat No lead Package (TQFN)

PACKAGE CODE: ZL

DOCUMENT CONTROL #: PD-2172

REVISION: --

14-0006

For latest package info.

 please check: <http://www.diodes.com/design/support/packaging/pericom-packaging/packaging-mechanicals-and-thermal-characteristics/>
Ordering Information

Ordering Code	Package Code	Package Description
PI3PCIE3242ZLEX	ZL	30-contact, Thin Fine Pitch Quad Flat No-Lead (TQFN), Tape & Reel

Notes:

- Thermal characteristics can be found on the company web site at www.diodes.com/design/support/packaging/
- E = Pb-free and Green
- Adding an X suffix = Tape/Reel

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